

Search Notes**Application/Control No.**

10/718,151

Examiner

ALEX LIEW

**Applicant(s)/Patent under
Reexamination**

LIN, I-JONG

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
348/586-589,592 limited to text search	3/25/2007	AL
382/173 limited to text search	3/25/2007	AL
382/154 limited to text search	8/31/2007	AL
348/586-589,592 limited to text search 382/154,173 limited to text search	4/14/2008	AL